

<b>Notice of References Cited</b>	Application/Control No. <b>09/700,031</b>	Applicant(s)/Patent Under Reexam <b>Iwamoto et al.</b>	
	Examiner <b>John Kim</b>	Art Unit <b>1723</b>	Page 1 of 1

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	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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B	3,668,837	6/1972	Gross	210	96
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N	352,917	1/1990	Europe	Thomson et al.	-----	-----
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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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<sup>1</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.